


<b>Search Notes</b>  	<b>Application/Control No.</b>  10550679	<b>Applicant(s)/Patent Under Reexamination</b>  GEIGER ET AL.
	<b>Examiner</b>  Faulk, Devona E	<b>Art Unit</b>  2615

SEARCHED			
Class	Subclass	Date	Examiner
381	56,57,59	3/27/2007	DEF
381	56-59, 1, 17, 19, 300, 307, 309, 310	11/15, 20/2007	DEF
381	60, 26, 74	11/21, 26/2007	DEF
702	108-112	11/26/2007	DEF
381	56, 57, 59, 1, 17, 26, 96 and 300	6/23/08	DEF

SEARCH NOTES		
Search Notes	Date	Examiner
Assignee/Inventor Search	3/27/2007	DEF
word search/combined class/word search	11/15, 20/2007	DEF
Consulted with Ping Lee, suggested additional search in 381/60 and to check with Huyen Le	11/21/2007	DEF
Consulted with Huyen Le, said no searches in their area of 381	11/21/2007	DEF
Consulted with Xu Mei, suggested additional searches in 381/26 and 74	11/21/2007	DEF
Consulted with Walter Briney, suggested additional search in 702/108-112	11/21/2007	DEF
Additional search	6/23/08, 7/6/08	DEF

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner